

**PATENT**

**Docket No. 29273/317**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

APPLICANTS : Kazumichi IMAI et al.  
SERIAL NO. : (Cont. of 09/852,269)  
FILED : (Herewith)  
FOR : ELECTROPHORESIS ANALYSIS APPARATUS  
AND SAMPLE VESSEL USED THEREFOR  
GROUP ART : 1744 (Anticipated)  
EXAMINER : A. Aldag (Anticipated)

COMMISSIONER FOR PATENTS  
P. O. Box 1450  
Alexandria, Virginia 22313-1450

**INFORMATION DISCLOSURE STATEMENT**  
**UNDER 37 C.F.R. § 1.97 & § 1.98**

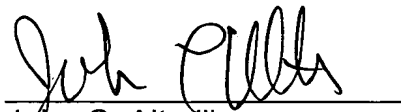
S I R:

In conformance with Applicants' duty of disclosure under 37 C.F.R. § 1.56 and § 1.97(b)(1), the references listed on the attached form PTO-1449 are hereby brought to the Examiner's attention.

Since all of the references have already been considered by the Examiner in parent application Serial No. 09/852,269, no copies of the references are required.

It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear in the "references cited" on any patent to issue therefrom.

Respectfully submitted,

  
\_\_\_\_\_  
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Dated: 26 February 2004

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**FORM PTO-1449**  
**INFORMATION DISCLOSURE**  
**STATEMENT BY APPLICANT(S)**

Atty Docket No. : 29273/317  
 Serial No. :  
 Applicants : K. IMAI et al.  
 Filed : (Herewith)  
 Group Art Unit :  
 Examiner :

**U.S. PATENT DOCUMENTS**

<u>Examiner Initial</u>	<u>Patent Number</u>	<u>Patent Date</u>	<u>Name</u>	<u>Class/ Subclass</u>	<u>Filing Date</u>
	5,916,428	05/29/99	KANE et al.	204/601	
	5,885,430	03/23/99	KERNAN et al.	204/453	
	5,730,850	03/24/98	KAMBARA et al.	204/603	
	5,585,069	12/17/96	ZANZUCCHI et al.	204/600	
	5,541,420	07/30/96	KAMBARA	204/602	
	5,439,578	08/08/95	DOVICH et al.	204/603	
	5,413,686	05/09/95	KLEIN et al.	204/603	
	5,384,024	01/24/95	MORING et al.	204/604	
	5,372,695	12/13/94	DEMAREST	204/603	
	5,366,608	11/22/94	KAMBARA	204/299	
	5,277,780	01/11/94	KAMBARA	204/299	
	5,274,240	12/28/93	MATHIES et al.	250/458	

**FOREIGN PATENT DOCUMENTS**

<u>Examiner Initial</u>	<u>Document Number</u>	<u>Date</u>	<u>Country</u>	<u>Class/ Subclass</u>	<u>Translation Yes No</u>

**OTHER DOCUMENTS**

(Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner  
Initial

1. JANSSON et al.: *Micro vials on a silicon wafer for sample introduction in capillary electrophoresis*, J. Chromatog., 626, pp. 310-314, 1992

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.